REASUNES

N Channel MOSFET

Applications:

- •Adapter & Charger
- •SMPS Standby Power
- •AC-DC Switching Power Supply
- •LED driving power

Features:

- •Low On Resistance
- •Low Gate Charge
- •Peak Current vs Pulse Width Curve
- •RoHS Compliant

📂 Lead Free Package and Finish

ID	RDS(ON) (Typ.)	Vdss
10A	0.75Ω	600V

2.Drain 2.Drain 1.Gate 0 Not to Scale

Ordering Information

Part Number	Package	Marking
RS10N60F	T0-220F	RS10N60F

Absolute Maximun Ratings Tc=25°C unless otherwise specified

Symbol	Parameter	RS10N60F	Units
VDSS	Drain-to-Source Voltage (Note*1)	600	V
ID	Continuous Drain Current	10.0	
ID@ 100 °C	Continuous Drain Current	7.0	А
IDM	Pulsed Drain Current (Note*2)	40.0	
DD	Power Dissipation	50	W
PD	Derating Factor above 25℃	0. 4	₩∕°C
VGS	Gate-to-Source Voltage	± 30	V
EAS	Single Pulse Avalanche Engergy L=30mH IAS=6.0A VDD=150V RG=25Ω TJ=25℃	654	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

*Drain Current Limited by Maximum Junction Temperature

Caution:Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.

Thermal Resistance

Symbol	Parameter	RS10N60F	Units	Test Conditions
Rejc	Junction-to-Case	2. 5	℃/W	Drain lead soldered to water cooled heatsink,PD adjusted for a peak junction temperature of +150°C.
Reja	Junction-to-Ambient	120		1 cubic foot chamber, free air.

RS10N60F

3.Source

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVdss	Drain-to-source Breakdown Voltage	600	_		V	Vgs=0V, Id=250µA
IDSS	Drain-to-Source Leakage Current		-	1.0	μĄ	VDS=600V, VGS=0V
Taga	Gate-to-Source Forward Leakage			100	A	VGS=+30V VDS=0V
IGSS	Gate-to-Source Reverse Leakage			-100	nA	VGS=-30V VDS=0V

OFF Characteristics TJ=25°C unless otherwise specified

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
RDS (on)	Static Drain-to-Source On- Resistance		0.75	1.0	Ω	VGS=10V, ID=5A
Vgs (TH)	Gate Threshold Voltage	2.0		4.0	V	VGS=VDS, ID=250µA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn-on Delay Time	-	32.33	-	nS	VDS=300V ID=10A
trise	Rise Time	-	60.40	-		
td(OFF)	Turn-OFF Delay Time	-	58.67	-		Rg=25 Ω
tfall	Fall Time	_	38.67	-		(Note:3,4)

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		1132			VGS=0V VDS=25V f=1.0MHz VDS=480V ID=10A VGS=10V (Note:3,4)
Coss	Output Capacitance		135		pF	
Crss	Reverse Transfer Capacitance		3.91			
Qg	Total Gate Charge		19.38			
Q_{gs}	Gate-to-Source Charge		6.26		nC	
Qgd	Gate-to-Drain("Miller") Charge		6.55			



Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Is	Continuous Source Current			10.0	А	Integral pn-diode
ISM	Maximum Pulsed Current			40.0	А	in MOSFET
VSD	Diode Forward Voltage			1.3	V	Is=10A, Vgs=0V
trr	Reverse Recovery Time		535.39	-	nS	V _{GS} =0V
$Q_{ m rr}$	Reverse Recovery Charge		4.6	-	μC	Is=10A, di/dt=100A/ μ s

Notes:

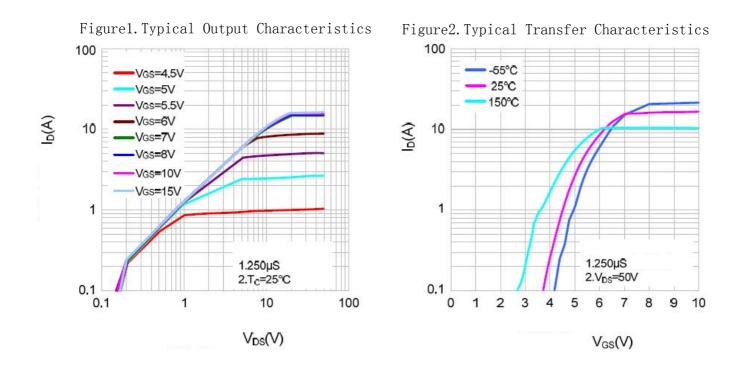
*1.TJ=±25℃ to +150℃.

*2. Repetitive rating; pulse width limited by maximum junction temperature.

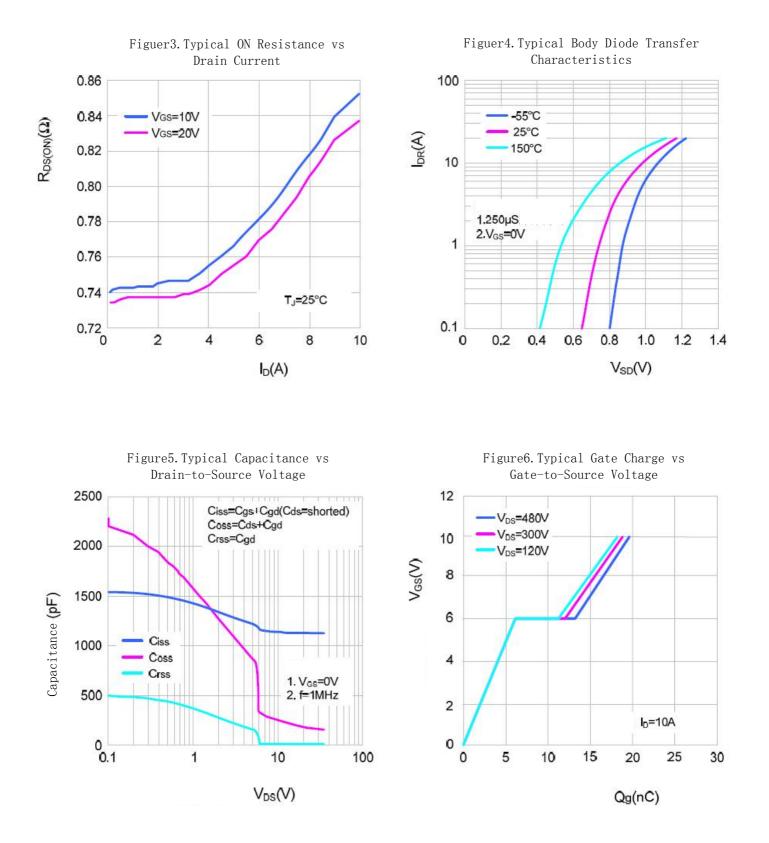
*3. Pulse width \leq 300 μ s; duty cycle \leq 2%.

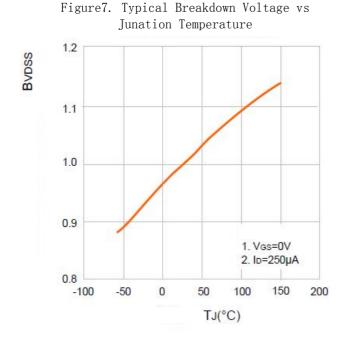
*4. Basically not affected by temperature.

Typical Feature curve



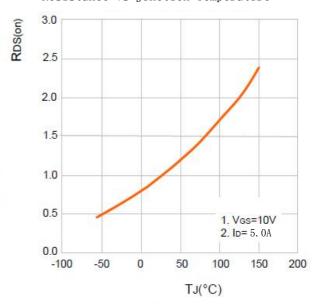


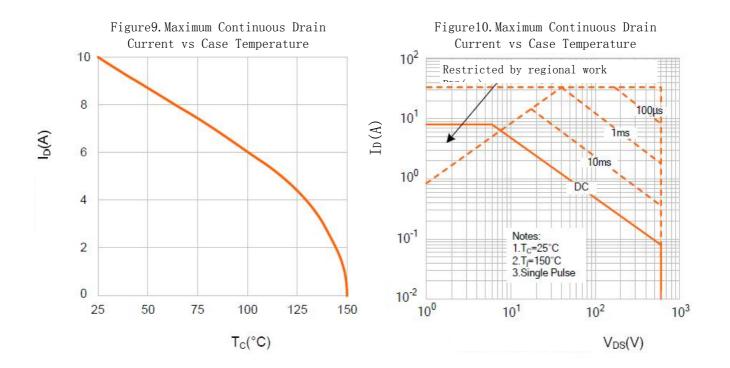




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Figure8. Figure10.Typical Drain-to-Source ON Resistance vs Junction Temperature







Test Circuits and Waveforms

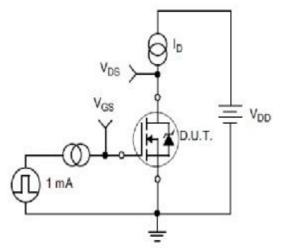


Figure11. Gate Charge Test Circuit

Vgs (TH)

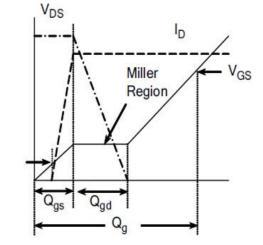
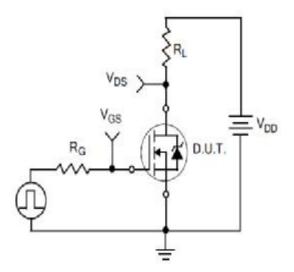


Figure12. Gate Charge Waveform



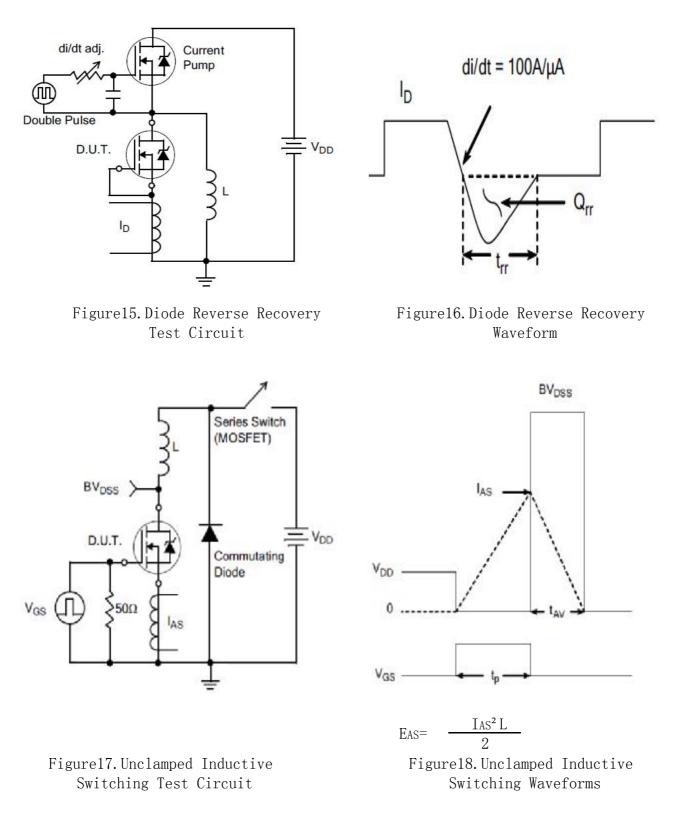
V_{DS} 90% 10% V_{GS} t_{d(ON)} t_{rise} t_{d(OFF)} t_{fall}

Figure13. Resistive Switching Test Circuit

Figure14. Resistive Switching Waveforms

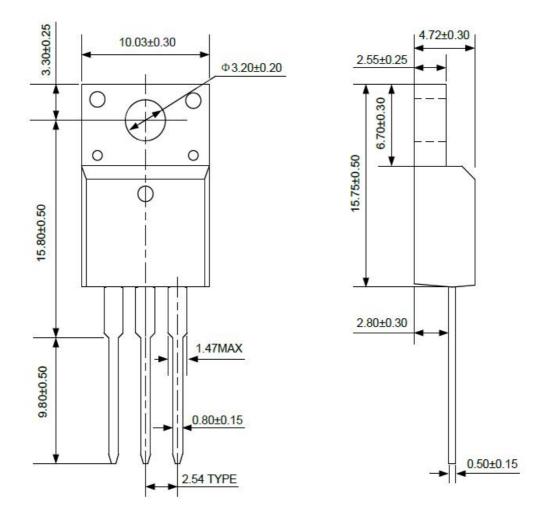


Test Circuits and Waveforms





Package outline drawing



T0-220F



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 - c.whose failuer to when properly used in accordance with instructions for used provided in the laeling, can be reasonably expected to result in significant injury to the user.
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